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## Correction: Reconstructing the phase of vanadium oxides enables redox-catalysis manipulated reversible sulfur conversion for stable Zn–S batteries

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Correction for 'Reconstructing the phase of vanadium oxides enables redox-catalysis manipulated reversible sulfur conversion for stable Zn–S batteries' by Hao Luo *et al.*, *Chem. Sci.*, 2025, <https://doi.org/10.1039/d4sc06593j>.

The original version of Fig. 5c showed the S 2p XPS spectrum for the original state in the 1.5 V data. This has been corrected in the new Fig. 5 given below, which shows S characteristic peaks at 163.0 eV and 167.88 eV during charging at 1.5 V.

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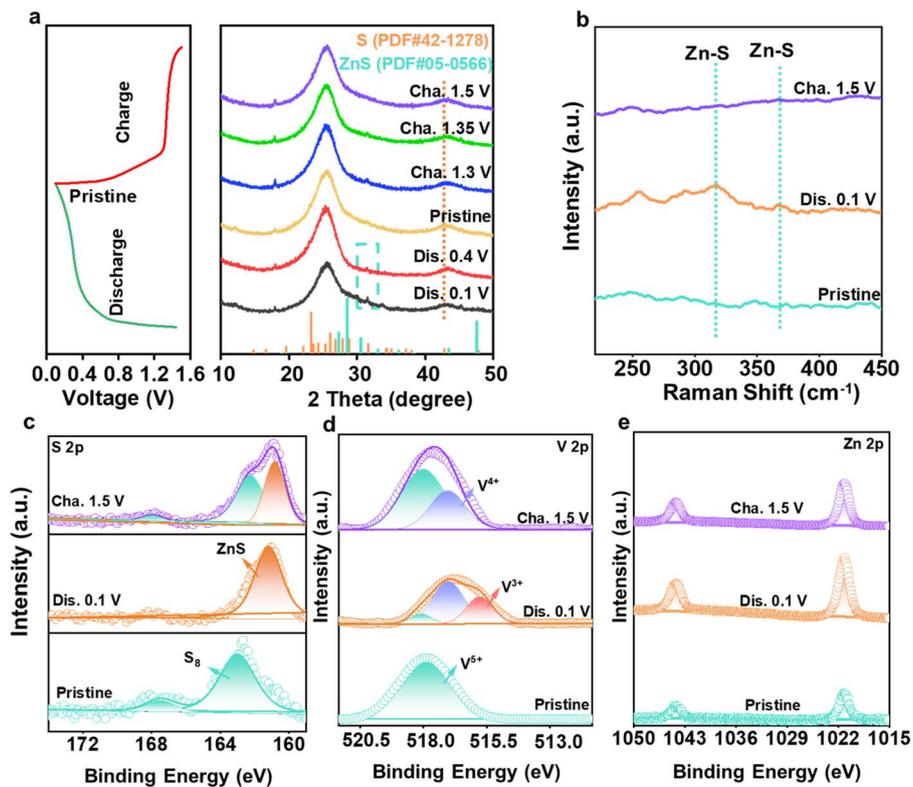


Fig. 5 Analysis of reversible sulfur redox conversion. (a) *Ex situ* XRD patterns collected at different states. (b) Raman spectra at different charge and discharge states. XPS spectra of (c) S 2p, (d) V 2p, and (e) Zn 2p at different states.

The overall conclusions from the rest of the study remain unchanged.

The Royal Society of Chemistry apologises for these errors and any consequent inconvenience to authors and readers.

